

PCA8802

Smartcard RTC; ultra low power oscillator with integrated counter for initiating one time password generation

Rev. 5 — 5 March 2013

Product data sheet

1. General description

The PCA8802 is a CMOS integrated circuit for battery operation, typically supplied by button cells or flexible polymer batteries. Incorporated is a 32.768 kHz quartz crystal oscillator circuit including the two load capacitors. The circuit is optimized for a quartz with 6 pF load capacitance specification. Higher values can also be used with the addition of external load capacitors.

The main function of the oscillator is to generate a $\frac{1}{32}$ Hz clock signal which is used to increment a 24 bit binary counter. The counter can be read over the serial interface and can also be set to any desired value. Control over the divider chain also allows for accurate starting of the counter. Incrementing of the counter value during read is prevented by freezing of the counter during access.

An interrupt signal is also available and is triggered coincident with the counter updating. This signal can be used as a wake-up for a microcontroller.

2. Features and benefits

- 32.768 kHz quartz oscillator, amplitude regulated with excellent frequency stability and high immunity to leakage currents
- Two integrated quartz crystal oscillator capacitors
- Very low current consumption: typically 130 nA
- Two-wire serial interface (I²C-bus)
- Integrated 24-bit counter with auto increment every 32 seconds
- Interrupt output for processor wake-up
- Stop function for accurate time setting and current saving during shelf life
- User test modes for accelerated application testing and development

3. Applications

- One time password function generators
- Ultra low-power time keeper circuit



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4. Ordering information

Table 1. Ordering information

Type number	Package			
	Name	Description	Version	
PCA8802CX8	WLCSP8	wafer level chip-size package; 8 bumps	PCA8802CX	
PCA8802U	WLCSP8	wafer level chip-size package; 8 bumps	PCA8802U	

4.1 Ordering options

Table 2. Ordering options

Product type number	Sales item (12NC)	Orderable part number	IC revision	Delivery form
PCA8802CX8/B/1	935288465027	PCA8802CX8/B/1,027	1	solder bumps; chips in tape and reel
PCA8802U/12AA/1[1]	935297673005	PCA8802U/12AA/1,00	1	sawn wafer on Film Frame Carrier (FFC)
PCA8802U/2AA/1[1]	935288535026	PCA8802U/2AA/1,026	1	chips in tray
PCA8802UG/12KB/1[1]	935299008005	PCA8802UG/12KB/1,0	1	sawn wafer on Film Frame Carrier (FFC)

^[1] Bump hardness see <u>Table 18</u>.

Table 3. PCA8802 wafer information

Product type number	Wafer thickness	Wafer diameter	FFC for wafer size	Marking of bad die
PCA8802U/12AA/1	200 μ m	6 inch	8 inch	wafer mapping
PCA8802UG/12KB/1	250 μ m	6 inch	8 inch	inking and wafer mapping

For packing information, see Section 16 "Packing information" on page 28.

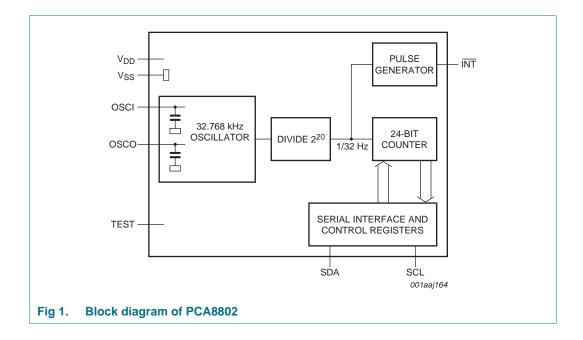
5. Marking

Table 4. Marking codes

Product type number	Marking code
PCA8802CX8/B/1	PC8802-1
PCA8802U/12AA/1	PC8802-1
PCA8802U/2AA/1	PC8802-1
PCA8802UG/12KB/1	PC8802-1

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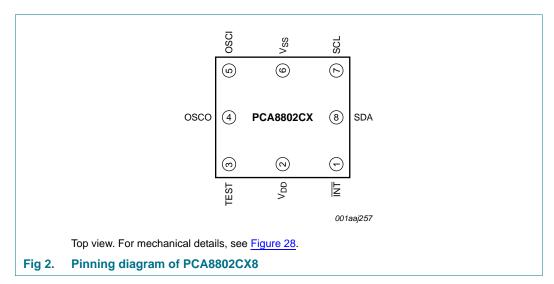
6. Block diagram

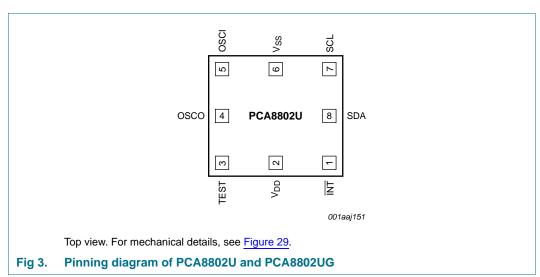


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7. Pinning information

7.1 Pinning





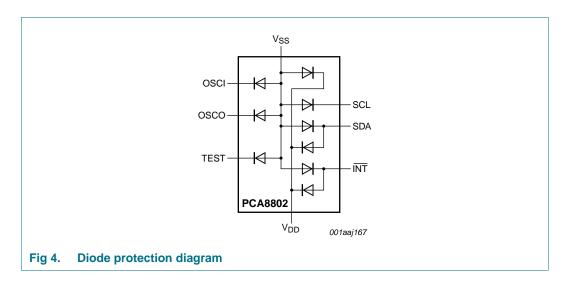
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7.2 Pin description

Table 5. Pin description for PCA8802

Symbol	Pin	Description
INT	1	interrupt and test mode output, push-pull
V_{DD}	2	supply voltage
TEST	3	test pin; must be connected to $V_{\mbox{\footnotesize SS}}$
OSCO	4	oscillator output
OSCI	5	oscillator input
V _{SS}	6	ground
SCL	7	serial interface, clock
SDA	8	serial interface, bidirectional data line; push-pull

8. Device protection diagram



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9. Functional description

The PCA8802 is an ultra low-power device for battery operations. The integrated oscillator circuit generates a $\frac{1}{32}$ Hz clock signal to increment a 24-bit counter. The communication between the PCA8802 and other devices is made via point to point I²C-bus protocol.

The device is always running but for longer storage time it can be put in deep sleep and enabled again in case of delivery.

The functions of the device can be controlled with the following instruction set:

Table 6. Instruction set overview

Instruction	Description	Reference
wrt_cmd	device write access	Section 9.6.2
dvs_cmd	divider start or stop switch	Section 9.6.3
pwd_cmd	deep sleep mode switch	Section 9.6.4
32k_cmd	32.768 kHz clock signal on the pin INT switch	Section 9.6.5
fst_cmd	fast system development mode switch	Section 9.6.6
set_cmd	set counter instruction	Section 9.6.7
rd_cmd	counter read instruction	Section 9.6.8

9.1 Oscillator

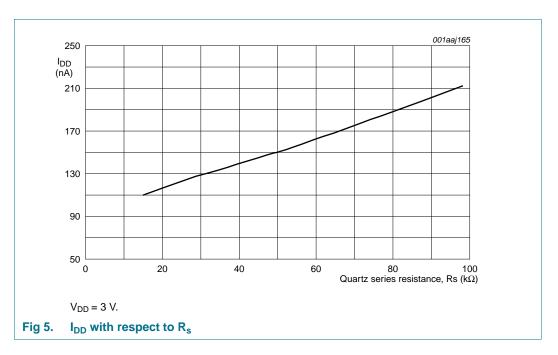
The 32.768 kHz oscillator includes two integrated load capacitors and an automatic gain control to ensure a reliable start-up.

For prototype development and system debugging, it is possible to output a 32.768 kHz square wave on the INT pin with the 32k_cmd instruction.

9.1.1 Low-power operation

When the oscillator is running, a prime consideration for low power consumption is the series resistance R_s of the quartz used. The series resistance acts as a loss element. Low R_s reduces current consumption further.

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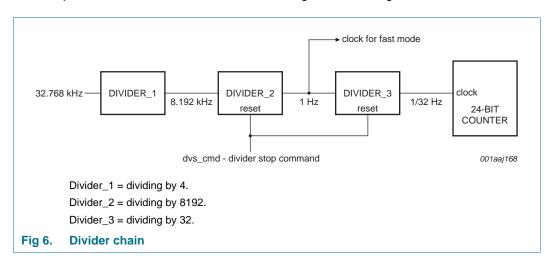
9.1.2 Deep sleep mode

With the deep sleep mode instruction (pwd_cmd) the oscillator can be stopped and the device can be put into a deep sleep where power consumption is reduced to an absolute minimum. An example sequence can be found in Table 9. In deep sleep mode, the interface is still accessible.

9.2 Divider

The divider chain is responsible for reducing the 32.768 kHz oscillator frequency down to 1_{32} Hz.

The dividers (see Figure 6) divider_2 and divider_3 can be reset with the dvs_cmd instruction. The 24-bit counter can be set when the dividers are held in reset, but this is not a requirement. This allows for accurate setting and restarting of the counter.



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The interface is asynchronous to the quartz oscillator and the state of divider_1 cannot be known when the dvs_cmd is enabled. The 8.192 kHz clock could have just occurred and hence a delay of $\frac{1}{8192}$ seconds will occur before the next increment of the divider_2, or the 8.192 kHz clock could be just about to occur and immediately increment the divider_2.

As a consequence, an uncertainty of between zero and one 8192 Hz clock period (that is, a time uncertainty of about 0 s to 122 μ s) will be present when restarting the counter.

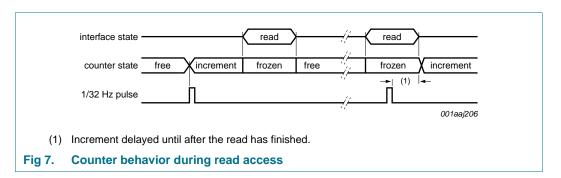
9.3 Binary counter

A 24-bit binary roll-over counter is implemented. The counter is reset at power-on.

The counter can be set to any value using the set_cmd instruction. The set_cmd instruction allows partial writing of data. Partial writing of the data parameters results in partial setting of the counter. For example, if data transfer is stopped after P1[23:16] (see Table 7) is transmitted, then only bit 23 to bit 16 will be updated. The counter will not increment while being set.

The counter can be halted by stopping the dividers using the dvs_cmd instruction.

The counter can be read at any time and the counter value remains stable during reading. If the counter is due to increment during the read or write cycle, then the request to increment will be held off until after the read has concluded. For this reason, it is important to read the counter in bursts, ensuring that an interface STOP condition (see Section 9.5.4) is present between read accesses. Reading for periods of more than 32 seconds at a time results in loss of counts.

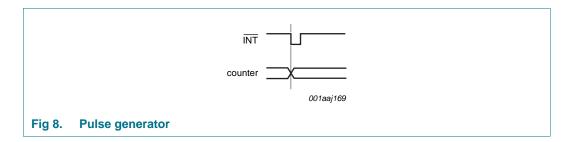


9.4 Pulse generator

An interrupt pulse is available at the $\overline{\text{INT}}$ pin. This pulse is generated once every 32 seconds. It could be used to wake up a microcontroller to perform a periodic function, for example, to calculate and update an LCD display with a new one-time password.

A pulse is generated coincident with the increment of the counter. The new counter value is immediately available.

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9.5 I²C-bus interface

9.5.1 Interface protocol

The serial interface is a point-to-point I²C-bus protocol. The I²C-bus protocol has the advantage of being robust in terms of immunity to electrical noise. Although the PCA8802 does not have the signal filters inside the interface pins, the slave address and acknowledge hand shaking is nevertheless implemented.

For power saving, the SDA output is a push-pull instead of the more traditional open-drain output. Push-pull prevents the need for power consuming pull-up resistors, but does limit the operation to point-to-point only.

The following slave addresses plus a write and read bit are reserved for the PCA8802:

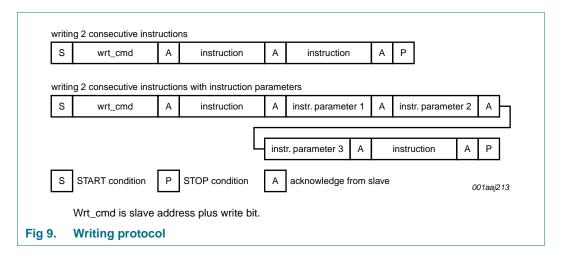
write: 1010 0000read: 1010 0001

An incorrect slave address results in the device ignoring all bus data. A STOP or START condition (see Section 9.5.4) is required before a new transfer can be made.

9.5.1.1 The writing protocol

The writing protocol is shown in Figure 9.

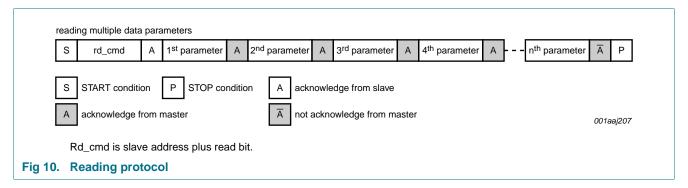
There is no restriction for the order of sending instructions. As many instructions as needed can be sent in one access. The total duration of one access must not exceed 32 seconds (see Figure 11).



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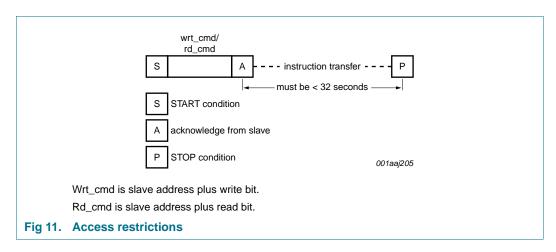
9.5.1.2 The reading protocol

The reading protocol is shown in Figure 10.



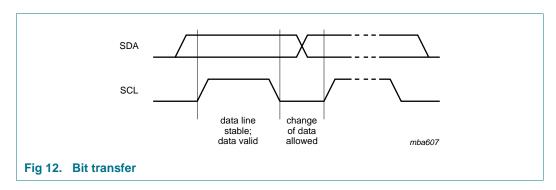
9.5.1.3 Reading and writing limitations

As the counter is frozen during interface accesses, all accesses must be completed within 32 seconds (see Figure 11). If this rule is not adhered to, then counts are dropped.



9.5.2 Bit transfer

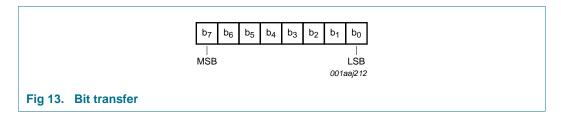
One data bit is transferred during each clock pulse. The data on the SDA line must remain stable during the HIGH period of the clock pulse as changes in the data line at this time are interpreted as a control signal. Bit transfer is shown in Figure 12.



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9.5.3 Bit order

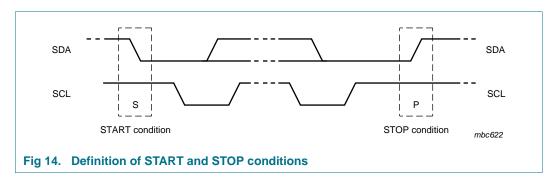
Data is transferred MSB first.



9.5.4 START and STOP conditions

Both data and clock lines remain HIGH when the bus is not busy. A HIGH-to-LOW transition of the data line, while the clock is HIGH is defined as the START condition (S). A LOW-to-HIGH transition of the data line while the clock is HIGH is defined as the STOP condition (P). The START and STOP conditions are shown in Figure 14.

The data on SDA is sampled with the rising edge of SCL. Data is output to SDA on the falling edge of SCL.



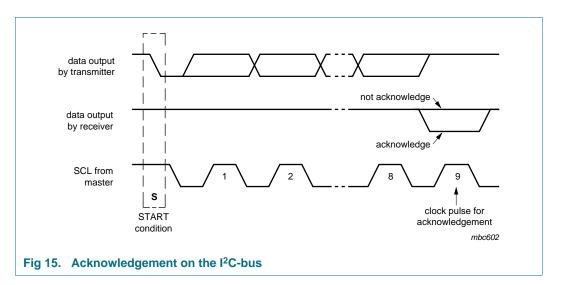
9.5.5 System configuration

A device generating a message is a transmitter, a device receiving a message is the receiver. The device that controls the message is the master and the device which is controlled by the master is the slave.

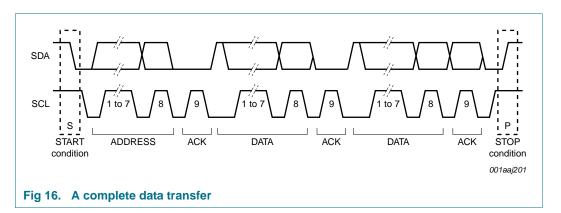
9.5.6 Acknowledge

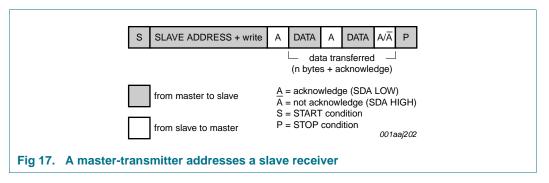
The number of data bytes transferred between the START and STOP conditions from transmitter to receiver is unlimited. But the duration of the access must not exceed 32 seconds. Each byte of 8 bits is followed by an acknowledge bit. The acknowledge bit is a HIGH level signal put on the bus by the transmitter during which time the master generates an extra acknowledge related clock pulse. A slave receiver which is addressed must generate an acknowledge after the reception of each byte. Also a master receiver must generate an acknowledge after the reception of each byte that has been clocked out of the slave transmitter. The device that acknowledges must pull-down the SDA line during the acknowledge clock pulse, so that the SDA line is stable LOW during the HIGH period of the acknowledge related clock pulse (set-up and hold times must be considered). A master receiver must signal an end of data to the transmitter by not generating an acknowledge on the last byte that has been clocked out of the slave. In this event, the transmitter must leave the data line HIGH to enable the master to generate a STOP condition. Acknowledgement is shown in Figure 15.

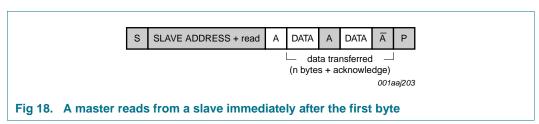
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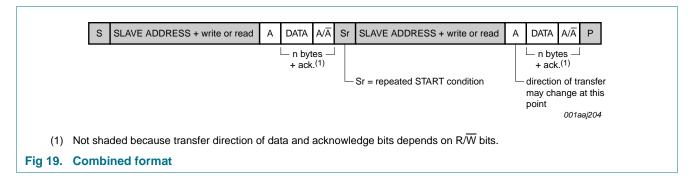
9.5.7 Data transfer





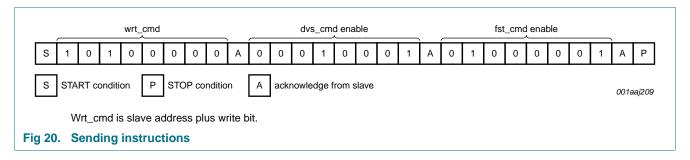


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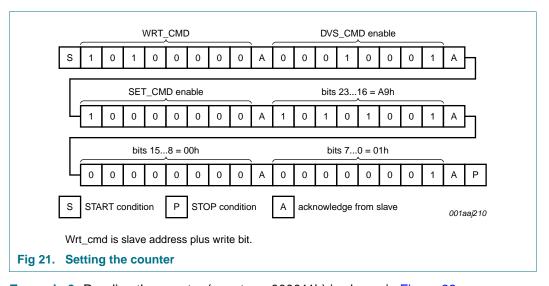


9.5.7.1 Example data transfers

Example 1: Sending the instruction dvs_cmd followed by fst_cmd is shown in Figure 20.

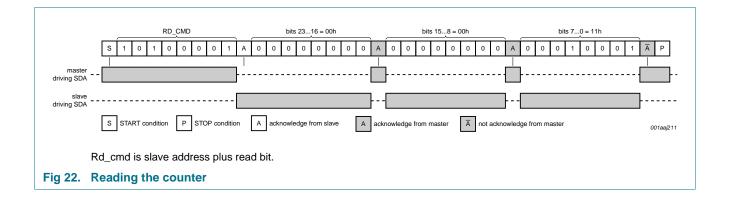


Example 2: Sending dvs_cmd followed by setting the counter to A90001h is shown in Figure 21



Example 3: Reading the counter (counter = 000011h) is shown in Figure 22.

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9.6 Instructions

9.6.1 Instruction set

Table 7. Write instructions

The writing protocol is illustrated in Figure 9.

First byte		Second byte		Further bytes	Action
Instruction	Instruction code	Instruction	Instruction code	Parameters	
wrt_cmd	1010 0000			-	device slave write address: slave address plus write bit
		dvs_cmd	0001 0001	-	stop and reset dividers
			0001 0000	-	start dividers
		pwd_cmd	0010 0001	-	shut down the device
			0010 0000	-	enable the device
		32k_cmd	0011 0001	-	enable output of 32.768 kHz on pin INT
			0011 0000	-	disable output of 32.768 kHz on pin INT
		fst_cmd	0100 0001	-	fast mode; increments counter every second
			0100 0000	-	fast mode disable
		set_cmd	1000 0000		set the counter value
				P1[23:16]	parameter with counter values
				P2[15:8]	
				P3[7:0]	

Table 8. **Read instructions**

The reading protocol is illustrated in Figure 10.

First byte		Further bytes	Action
Instruction	Instruction code	Parameters	
rd_cmd ^[1]	1010 0001		device slave read address: slave address plus read bit
		P1[23:16]	parameter with counter values;
		P2[15:8]	continues to read until no ACK is received;
		P3[7:0]	counter is not updated during this time
		P4[23:16]	
		:	

^[1] Read of the counter is implicit with an interface read.

9.6.2 Instruction wrt_cmd

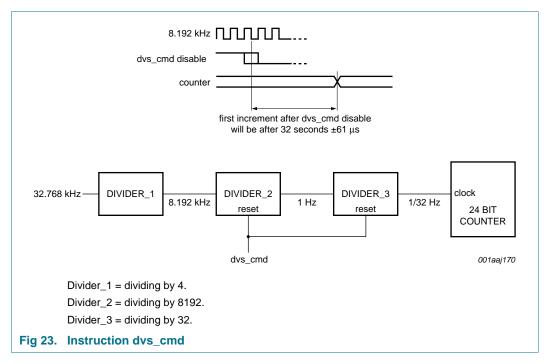
The write instruction (wrt_cmd) precedes each write sequence. Details of the writing protocol can be found in Section 9.5.1.1.

9.6.3 Instruction dvs_cmd

The divider stop instruction (dvs_cmd) can be used to freeze the divider chain and to put it in a defined state. The first 2 bits of the divider chain cannot be influenced. With this instruction, it is possible to control the time to the next increment of the counter. See Table 10.

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When the dividers are restarted, the first increment of the 24-bit counter will be after 32 seconds.



When the dividers are restarted, the 8192 Hz clock could have just occurred and hence a delay of $\frac{1}{8192}$ seconds will occur before the next increment of the divider_2. Or the 8192 Hz clock could be just about to occur and immediately increment the divider_2. As a consequence, an uncertainty of one half clock period in the starting of the 24 bit counter is present when restarting (see Figure 23).

9.6.4 Instruction pwd_cmd

The power down instruction (pwd_cmd) is intended to be used to put the system into a low-power mode for storage. Static leakage current will be the only power consumed. Storage at temperatures exceeding room temperature can increase leakage currents.

Entering deep sleep mode requires a specific sequence of events since under normal circumstances stopping the oscillator would result in a chip reset.

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Table 9. Deep sleep mode sequence

Step	Action	Code sequence	Note
To en	ter deep sleep mode		
1	initiate transfer	START condition	-
2	send wrt_cmd	1010 0000	-
3	enable dvs_cmd	0001 0001	stop the divider
4	set counter with set_cmd	1000 0000	set the counter = AAAAAAh
		1010 1010	P1[23:16]
		1010 1010	P2[15:8]
		1010 1010	P3[7:0]
5	enable pwd_cmd	0010 0001	stop the oscillator
6	end transfer	STOP condition	-
7	device is now in deep sleep mode	-	-
То ех	it deep sleep mode		
1	initiate transfer	START condition	-
2	send wrt_cmd	1010 0000	-
3	disable pwd_cmd	0010 0000	oscillator starts on the ACK cycle of this instruction
4	disable dvs_cmd	0001 0000	enable the divider again
5	end transfer	STOP condition	-

9.6.5 Instruction 32k_cmd

The 32.768 kHz enable instruction (32k_cmd) is intended to aid with oscillator characterization during system development. With this instruction, it is possible to obtain a 32.768 kHz clock on the INT pin which can be used for measurement.

This mode does not affect other operation of the chip except for the loss of interrupt output.

9.6.6 Instruction fst_cmd

The fast mode instruction (fst_cmd) is intended to enable faster system development. When enabled, the counter increments once every second instead of once every 32 seconds. Interrupt pulses are generated once every second as well.

When using fst_cmd, data access to the device must be completed within 1 second, if not then counter increments are lost. The 1 second period is measured from the ACK cycle of a valid slave address to the next STOP or repeated START. A repeated START is sufficient to allow the counter to increment.

9.6.7 Instruction set_cmd

The counter can be set to any value using the set instruction (set_cmd). Partial writing of the data parameters results in partial setting of the counter. For example, if data transfer is stopped after P1[23:16] is transmitted, then only bit 23 to bit 16 will be updated.

This instruction takes only 3 parameters in one command. Data after the third parameter are interpreted as the next instruction.

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Accurate setting and start-up can be implemented using the dvs_cmd instruction in cooperation with the set_cmd instruction. An example is shown in Table 10.

Table 10. Example of accurate setting of the counter

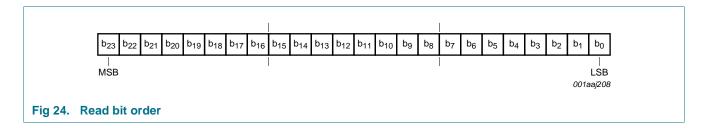
	•	_	
Step	Action	Code sequence	Note
1	initiate transfer	START condition	-
2	send wrt_cmd	1010 0000	-
3	enable dvs_cmd	0001 0001	-
4	set counter with set_cmd	1000 0000	set the counter = 1
		0000 0000	P1[23:16]
		0000 0000	P2[15:8]
		0000 0001	P3[7:0]
5	end transfer	STOP condition	-
6	wait for an external time marker	-	-
7	initiate transfer	START condition	-
8	send wrt_cmd	1010 0000	-
9	disable dvs_cmd	0001 0000	counter starts on the ACK cycle of this instruction
10	end transfer	STOP condition	-

9.6.8 Instruction rd_cmd

With the read instruction (rd_cmd) the counter value can be read at any time. When the counter value is read, the counter is frozen so that there are no changes during the read back. After a read is terminated, the counter will be allowed to increment again. Any increment that was scheduled during the frozen period will then be effected.

Reading the counter is cyclic, that is, the device repeatedly returns the present counter value until the read is terminated. Reading the counter more than once can be useful in the case that the application is subject to a strong Electromagnetic Interference (EMI) environment, so that read-back values can be compared.

Read back must be terminated within 32 seconds else a count will be dropped.



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9.7 Power-on reset

At initial power-on a reset is generated. The reset lasts not longer than 10 ms. During this time, the serial interface will not respond when accessed. The state of the device after power-on reset is shown in Table 11.

Table 11. Reset state

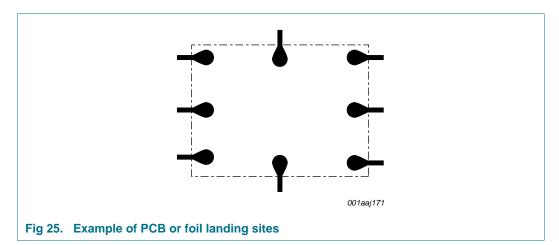
Instruction name	State after reset
dvs_cmd	disabled
pwd_cmd	disabled
32k_cmd	disabled
fst_cmd	disabled
24-bit counter	000000h

10. Application design-in information

10.1 PCB or foil landing site

The layout of the landing sites is important. It is recommended to follow the following guidelines

- All landing sites should be the same size. When one site has a different size or shape, e.g. to indicate pad one, then the pull on the die produced by the surface tension of the solder will be different in one place. This variation can lead to the die not laying flat on the Printed-Circuit Board (PCB) or foil. This can also result in weak solder joints for some pins.
- It is recommended to use circular landing sites of the same diameter as the solder ball. This will help with self alignment. Solder bump dimensions can be found in Figure 28.
- 3. If no solder resist is used on the PCB or foil, then consideration should be given to the amount of run-off of the solder along the track connected to the landing site. Uneven run-off may result in similar problems as described in 1.



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11. Limiting values

Table 12. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DD}	supply voltage		-0.5	+6.5	V
I_{DD}	supply current		-50	+50	mA
V_{I}	input voltage		-0.5	+6.5	V
I _I	input current		-10	+10	mA
Vo	output voltage		-0.5	+6.5	V
I _O	output current		-10	+10	mA
P _{tot}	total power dissipation		-	300	mW
V _{esd}	electrostatic discharge voltage	HBM	[1] -	±2500	V
		MM	[2] _	±200	V
l _{lu}	latch-up current		[3]	200	mΑ
T _{amb}	ambient temperature		-40	+85	°C
T _{stg}	storage temperature		<u>[4]</u> –65	+150	°C

^[1] Pass level; Human Body Model (HBM) according to JESD22-A114.

^[2] Pass level; Machine Model (MM), according to JESD22-A115.

^[3] Pass level; Latch-up testing, according to JESD78.

^[4] According to the store and transport requirements (see Ref. 11 "UM10569") the devices have to be stored at a temperature of +8 $^{\circ}$ C to +45 $^{\circ}$ C and a humidity of 25 $^{\circ}$ 6 to 75 $^{\circ}$ 8.

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12. Static characteristics

Table 13. Static characteristics

 V_{DD} = 1.6 V to 5.5 V; V_{SS} = 0 V; f_{osc} = 32.768 kHz; T_{amb} = -40 °C to +85 °C; quartz crystal: R_s = 30 k Ω , C_L = 6.0 pF; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Supplies							
V_{DD}	supply voltage			1.6	-	5.5	V
		$T_{amb} = 25 ^{\circ}C;$ $f_{SCL} = 0 Hz$		-	1.0	-	V
ΔV_{DD}	supply voltage variation	$\Delta V/\Delta t = 1 V/\mu s$		-	0.25	-	V
I _{DD}	supply current	deep sleep active	<u>[1]</u>				
		$T_{amb} = 25 ^{\circ}\text{C};$ $V_{DD} = 3 \text{V};$ $f_{SCL} = 0 \text{Hz}$		-	3	-	nA
		device running					
		f _{SCL} = 0 Hz		-	-	400	nA
		$T_{amb} = 25 ^{\circ}C;$ $V_{DD} = 3 V;$		-	130	-	nA
		$f_{SCL} = 0 Hz$					
		interface active					
		$f_{SCL} = 100 \text{ kHz}$		-	5	20	μΑ
		f _{SCL} = 1 MHz		-	50	100	μΑ
Oscillator							
V_{start}	start voltage			-	1.1	-	V
t _{startup}	start-up time			-	0.2	-	S
C _{L(itg)}	integrated load capacitance		[2]	-	6.0	-	pF
Inputs							
V_{IL}	LOW-level input voltage			-	-	$0.3V_{DD}$	V
V_{IH}	HIGH-level input voltage			$0.7V_{DD}$	-	-	V
V_{I}	input voltage	on pins SCL, OSCI, TEST		-0.5	-	5.5	V
		on pin SDA		-0.5	-	$V_{DD} + 0.5$	V
I _{LI}	input leakage current	$V_I = V_{DD}$ or V_{SS} ; on pins SCL, SDA and TEST		-200	0	+200	nA
Outputs							
Vo	output voltage			-0.5	-	V _{DD} +0.5	V
I _{OH}	HIGH-level output current	$V_{OH} = 4.0 \text{ V};$ $V_{DD} = 5 \text{ V};$ on pins INT and SDA		-	5	2	mA
		V_{OH} = 1.28 V; V_{DD} = 1.6 V; on pins \overline{INT} and SDA		-	0.5	0.2	mA

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Table 13. Static characteristics ... continued

 V_{DD} = 1.6 V to 5.5 V; V_{SS} = 0 V; f_{osc} = 32.768 kHz; T_{amb} = -40 °C to +85 °C; quartz crystal: R_s = 30 k Ω , C_L = 6.0 pF; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{OL}	LOW-level output current	$V_{OL} = 1.0 \text{ V};$ $V_{DD} = 5 \text{ V};$ on pins INT and SDA	-2	-7	-	mA
		$V_{OL} = 0.32 \text{ V};$ $V_{DD} = 1.6 \text{ V};$ on pins $\overline{\text{INT}}$ and SDA	-0.4	–1	-	mA
I_{LO}	output leakage current	$V_O = V_{DD}$ or V_{SS} ; on pins SDA and \overline{INT}	-200	0	+200	nA

^[1] Unless otherwise defined, I_{DD} is measured with the reset state, see Section 9.7.

^[2] Integrated load capacitance, $C_{L(itg)}$, is a calculation of C_{OSCI} and C_{OSCO} in series: $C_{L(itg)} = \frac{(C_{OSCI} \cdot C_{OSCO})}{(C_{OSCI} + C_{OSCO})}$.

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13. Dynamic characteristics

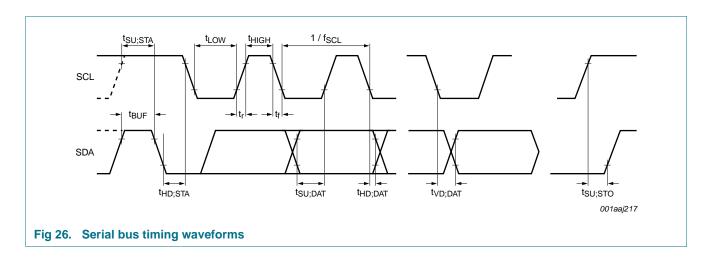
Table 14. Dynamic characteristics

 V_{DD} = 1.6 V to 5.5 V; V_{SS} = 0 V; T_{amb} = -40 °C to +85 °C; unless otherwise specified. [1]

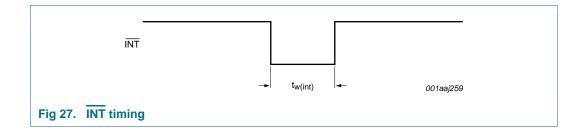
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Timing cha	aracteristics: serial bus						
f _{SCL}	SCL clock frequency			-	-	1	MHz
t_{LOW}	LOW period of the SCL clock			500	-	-	ns
t _{HIGH}	HIGH period of the SCL clock			260	-	-	ns
t _{BUF}	bus free time between a STOP and START condition			500	-	-	ns
t _{HD;STA}	hold time (repeated) START condition			260	-	-	ns
t _{SU;STA}	set-up time for a repeated START condition			260	-	-	ns
t _r	rise time of both SDA and SCL signals		[2]	-	10	-	ns
t _f	fall time of both SDA and SCL signals		[2]	-	10	-	ns
t _{SU;DAT}	data set-up time			50	-	-	ns
$t_{HD;DAT}$	data hold time			0	-	-	ns
t _{SU;STO}	set-up time for STOP condition			260	-	-	ns
$t_{\text{VD;DAT}}$	data valid time			75	-	450	ns
C _b	capacitive load for each bus line			-	-	50	pF
Timing cha	aracteristics: INT						
t _{w(int)}	interrupt pulse width			20	40	80	μS

^[1] All timing values are valid within the operating supply voltage and ambient temperature range and are referenced to V_{IL} and V_{IH} with an input voltage swing of V_{SS} to V_{DD} .

^[2] Rise and fall times are not limited. Fast edges can lead to system EMI problems, while slow edges are susceptible to noise.



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14. Bare die outline

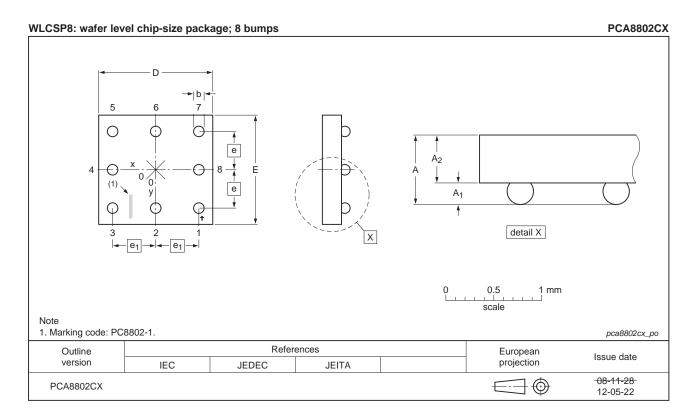


Fig 28. Bare die outline PCA8802CX

Table 15. Dimensions of PCA8802CX

Original dimensions are in mm.

Unit (mm)	Α	A_1	A_2	b	D	E	е	e ₁	e _D
max	-	0.105	-	0.136	-	-	-	-	-
nom	0.29	0.090	0.2	0.109	1.19	1.14	0.4	0.45	0.96
min	-	0.075	-	0.082	-	-	-	-	-

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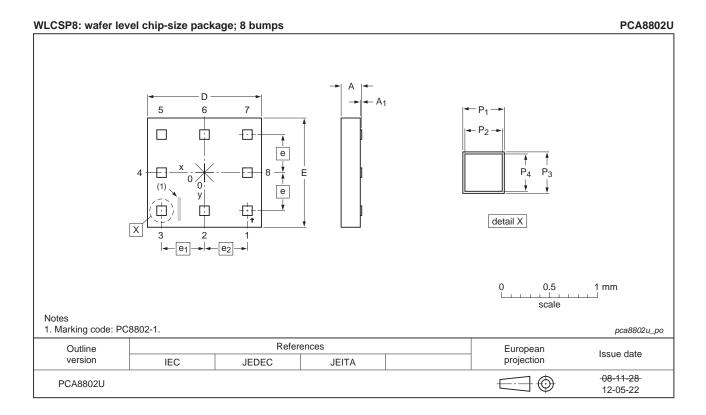


Fig 29. Bare die outline PCA8802U

Table 16. Dimensions of PCA8802U and PCA8802UG *Original dimensions are in mm.*

Unit (mm)	Α	A ₁	D	E	е	e ₁	e ₂	P ₁ [1]	P ₂ [2]	P ₃ [1]	P ₄ [2]
PCA8802U/	PCA8802U/2AA/1 and PCA8802U/12AA/1										
max	-	0.018	-	-	-	-	-	-	0.093	-	0.093
nom	0.215	0.015	1.19	1.14	0.396	0.448	0.449	0.099	0.090	0.099	0.090
min	-	0.012	-	-	-	-	-	-	0.087	-	0.087
PCA8802U	G/12KB/	1									
max	-	0.018	-	-	-	-	-	-	0.093	-	0.093
nom	0.265	0.015	1.19	1.14	0.396	0.448	0.449	0.099	0.090	0.099	0.090
min	-	0.012	-	-	-	-	-	-	0.087	-	0.087

^[1] Pad size.

^[2] Bump size.

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Table 17. Bump and reference point locations of PCA8802U and PCA8802UG

Symbol	Pad	Coordinates[1]			
		x	у		
INT	1	437	-396		
V_{DD}	2	-12	-430		
TEST	3	-460	-396		
OSCO	4	-460	1		
OSCI	5	-460	396		
V _{SS} [2]	6	-12	430		
SCL	7	437	396		
SDA	8	437	1		
pin 1 identifier	-	474.7	-472.0		
bottom left die corner[3]	-	-594.8	-568.2		
top right die corner[3]	-	594.7	568.3		

- [1] All coordinates are referenced, in μ m, to the center of the die (see Figure 29).
- [2] The substrate (rear side of the die) is connected to V_{SS} and should be electrically isolated.
- [3] Die size before dicing. Final dimensions will be 10 μm to 20 μm smaller.

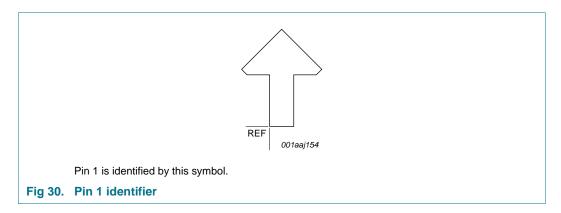


Table 18. Gold bump hardness of PCA8802U and PCA8802UG

Gold bump type	Min	Max	Unit ^[1]
soft gold bump	35	80	HV

^[1] Pressure of diamond head: 10 g to 50 g.

15. Handling information

All input and output pins are protected against ElectroStatic Discharge (ESD) under normal handling. When handling Metal-Oxide Semiconductor (MOS) devices ensure that all normal precautions are taken as described in *JESD625-A*, *IEC 61340-5* or equivalent standards.

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16. Packing information

16.1 Tape and reel information for PCA8802CX8/B/1

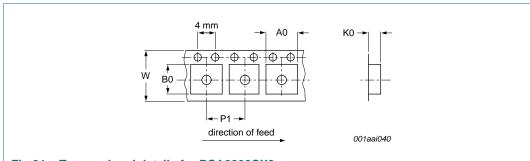


Fig 31. Tape and reel details for PCA8802CX8

Table 19. Tape and reel dimensions [1]

Dimension	Description	Value
W	tape width	8.0 mm
A0	pocked length	1.3 mm
B0	pocket width	1.3 mm
K0	pocket depth	0.5 mm
P1	pocket pitch	4.0 mm

[1] Die is placed in pocket bump side down.

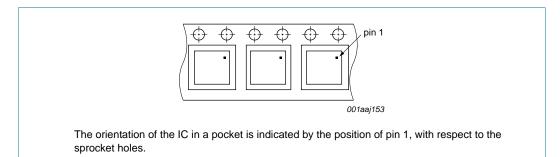
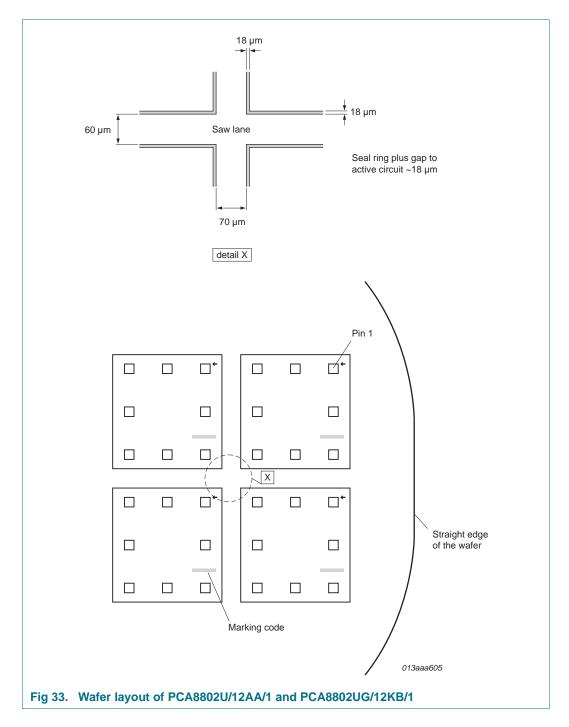
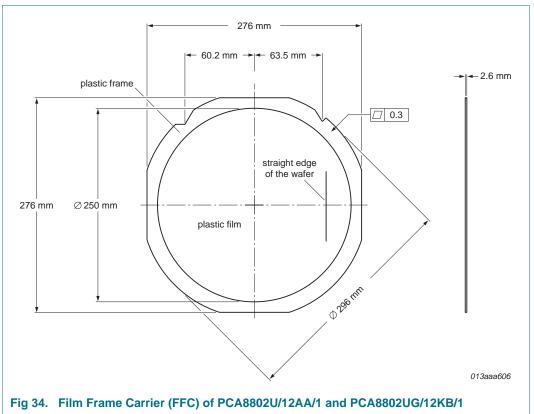


Fig 32. Pocket alignment for PCA8802CX8

16.2 Wafer and Film Frame Carrier (FFC) information for PCA8802U/12AA/1 and PCA8802UG/12KB/1



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16.3 Tray information for PCA8802U/2AA/1

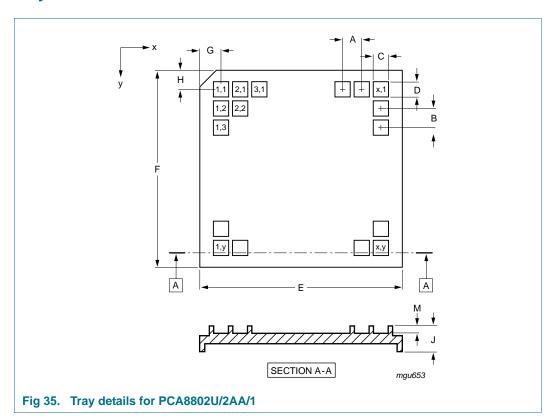
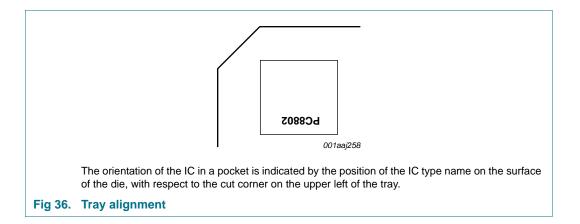


Table 20. Tray dimensions [1]

Dimension	Description	Value
Α	pocket pitch; x direction	3.1 mm
В	pocket pitch; y direction	3.1 mm
С	pocket width; x direction	1.29 mm
D	pocket width; y direction	1.24 mm
E	tray width; x direction	50.8 mm
F	tray width; y direction	50.8 mm
G	distance from cut corner to pocket (1,1) center	5.25 mm
Н	distance from cut corner to pocket (1,1) center	5.25 mm
J	tray thickness	3.96 mm
M	pocket depth	0.5 mm
x	number of pockets in x direction	14
у	number of pockets in y direction	14

^[1] Die is placed in pocket bump side up.

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17. Soldering of WLCSP packages

17.1 Introduction to soldering WLCSP packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering WLCSP (Wafer Level Chip-Size Packages) can be found in application note AN10439 "Wafer Level Chip Scale Package" and in application note AN10365 "Surface mount reflow soldering description".

Wave soldering is not suitable for this package.

All NXP WLCSP packages are lead-free.

17.2 Board mounting

Board mounting of a WLCSP requires several steps:

- 1. Solder paste printing on the PCB
- 2. Component placement with a pick and place machine
- 3. The reflow soldering itself

17.3 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 37</u>) than a PbSn process, thus reducing the process window
- Solder paste printing issues, such as smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature), and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic) while being low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 21.

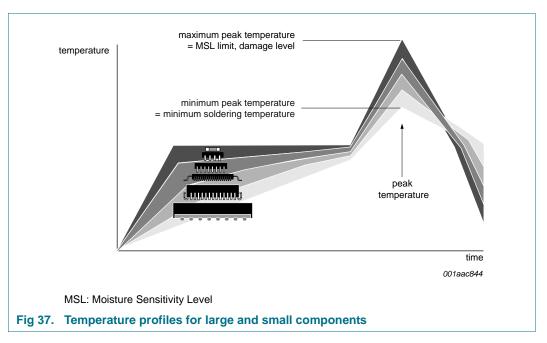
Table 21. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)					
	Volume (mm ³)					
	< 350	350 to 2000	> 2000			
< 1.6	260	260	260			
1.6 to 2.5	260	250	245			
> 2.5	250	245	245			

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 37.

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For further information on temperature profiles, refer to application note *AN10365* "Surface mount reflow soldering description".

17.3.1 Stand off

The stand off between the substrate and the chip is determined by:

- The amount of printed solder on the substrate
- The size of the solder land on the substrate
- The bump height on the chip

The higher the stand off, the better the stresses are released due to TEC (Thermal Expansion Coefficient) differences between substrate and chip.

17.3.2 Quality of solder joint

A flip-chip joint is considered to be a good joint when the entire solder land has been wetted by the solder from the bump. The surface of the joint should be smooth and the shape symmetrical. The soldered joints on a chip should be uniform. Voids in the bumps after reflow can occur during the reflow process in bumps with high ratio of bump diameter to bump height, i.e. low bumps with large diameter. No failures have been found to be related to these voids. Solder joint inspection after reflow can be done with X-ray to monitor defects such as bridging, open circuits and voids.

17.3.3 Rework

In general, rework is not recommended. By rework we mean the process of removing the chip from the substrate and replacing it with a new chip. If a chip is removed from the substrate, most solder balls of the chip will be damaged. In that case it is recommended not to re-use the chip again.

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Device removal can be done when the substrate is heated until it is certain that all solder joints are molten. The chip can then be carefully removed from the substrate without damaging the tracks and solder lands on the substrate. Removing the device must be done using plastic tweezers, because metal tweezers can damage the silicon. The surface of the substrate should be carefully cleaned and all solder and flux residues and/or underfill removed. When a new chip is placed on the substrate, use the flux process instead of solder on the solder lands. Apply flux on the bumps at the chip side as well as on the solder pads on the substrate. Place and align the new chip while viewing with a microscope. To reflow the solder, use the solder profile shown in application note *AN10365 "Surface mount reflow soldering description"*.

17.3.4 Cleaning

Cleaning can be done after reflow soldering.

18. Abbreviations

Table 22. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
EMI	ElectroMagnetic Interference
НВМ	Human Body Model
IC	Integrated Circuit
LCD	Liquid Crystal Display
LSB	Least Significant Bit
MM	Machine Model
MSB	Most Significant Bit
PCB	Printed-Circuit Board
RTC	Real-Time Clock
WLCSP	Wafer Level Chip-Size Package

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19. References

- [1] AN10439 Wafer Level Chip Size Package
- [2] AN10706 Handling bare die
- [3] AN10853 ESD and EMC sensitivity of IC
- [4] IEC 60134 Rating systems for electronic tubes and valves and analogous semiconductor devices
- [5] IEC 61340-5 Protection of electronic devices from electrostatic phenomena
- [6] JESD22-A114 Electrostatic Discharge (ESD) Sensitivity Testing Human Body Model (HBM)
- [7] **JESD22-A115** Electrostatic Discharge (ESD) Sensitivity Testing Machine Model (MM)
- [8] JESD78 IC Latch-Up Test
- [9] JESD625-A Requirements for Handling Electrostatic-Discharge-Sensitive (ESDS) Devices
- [10] UM10204 I²C-bus specification and user manual
- [11] UM10569 Store and transport requirements

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20. Revision history

Table 23. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PCA8802 v.5	20130305	Product data sheet	-	PCA8802 v.4
Modifications:	 Adjusted prod 	duct types and related	d packing	
PCA8802 v.4	20120927	Product data sheet	-	PCA8802 v.3
PCA8802 v.3	20120330	Product data sheet	-	PCA8802 v.2
PCA8802 v.2	20120126	Product data sheet	-	PCA8802_1
PCA8802_1	20090219	Product data sheet	-	-

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21. Legal information

21.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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